	FOR	FORM PTO-1449 (MODIFIED)			ATTORNEY DOCKET NO. SP04-026			SERIAL NO.					
	LIST OF PATENTS AND PUBLICATIONS				SF04-020			10/822,385					
E	FOR APPLICANTS INFORMATION DISCLOSURE STATEMENT					APPLICANT: Ye Fang, et al.							
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	u	AA	6,824,866 B1	11/30/2	004 Glazer et al		-						
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cc	AA	4,544,395	10-01-8	5 Brian Eva	ns	65	\neg	60.3			
. 1	AB	5,585,136	12-1996	Barrow et	al.	427		2.24			
	AC	5,770,722	06-23-9	8 David J. L	ockhart et al.	536		25.3	1		
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a.	AI	6,306,348	10-2001	Havens et	Havens et al.			68.1			
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u	AS Thomas H. Elmer, "Porous and Reconstructed Glasses", Engineered Materials Handbook, Vol. 4, The Materials Information Society, pgs. 427-432								formation		
a	AT	M. Glazer et al., "Colloidal Silica Films For High-Capacity DNA Probe Arrays", Chem. Mater. 2001, Vol. 13, pgs. 4773-4782									
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EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609: draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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	AA	6,750,023	6/15/04	Tanner et al					
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u	AA	5,679,310	10-21-97	Roy L. Manns	422	102					
	AB	5,861,306	01-19-99	Sydney M. Pugh et al.	435	288.4					
	AC	6,238,624	05-29-01	Michael J. Heller et al.	422	68.1					
	AD	2002/0102578	08-01-02	Todd Dickinson et al.	435	6					
u	AE	2004/0022677	02-05-04	J.N. Wohlstadter et al.	422	52	52				
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